## Switching，Inverter Circuit，Interface Circuit

 And Driver Circuit Applications－Includeing two devices in US6（ultra super mini type with 6 leads）
－With built－in bias resistors
－Simplify circuit design
－Reduce a quantity of parts and manufacturing process
Equivalent Circuit and Bias Resister Values




R1： $47 \mathrm{k} \Omega$
R2： $47 \mathrm{k} \Omega$
（Q1，Q2 Common）

Q1 Maximum Ratings $\left(\mathbf{T a}=25^{\circ} \mathrm{C}\right)$

| Characteristic | Symbol | Rating | Unit |
| :--- | :---: | :---: | :---: |
| Collector－base voltage | $\mathrm{V}_{\text {CBO }}$ | -50 | V |
| Collector－emitter voltage | $\mathrm{V}_{\text {CEO }}$ | -50 | V |
| Emitter－base voltage | $\mathrm{V}_{\text {EBO }}$ | -10 | V |
| Collector current | $\mathrm{I}_{\mathrm{C}}$ | -100 | mA |



Q2 Maximum Ratings $\left(\mathbf{T a}=25^{\circ} \mathrm{C}\right)$

| Characteristic | Symbol | Rating | Unit |
| :--- | :---: | :---: | :---: |
| Collector－base voltage | $\mathrm{V}_{\text {CBO }}$ | 50 | V |
| Collector－emitter voltage | $\mathrm{V}_{\text {CEO }}$ | 50 | V |
| Emitter－base voltage | $\mathrm{V}_{\text {EBO }}$ | 10 | V |
| Collector current | $\mathrm{I}_{\mathrm{C}}$ | 100 | mA |

## Q1, Q2 Common Maximum Ratings ( $\mathbf{T a}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )

| Characteristic | Symbol | Rating | Unit |
| :--- | :---: | :---: | :---: |
| Collector power dissipation | $\mathrm{PC}^{*}$ | 200 | mW |
| Junction temperature | $\mathrm{T}_{\mathrm{j}}$ | 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature range | $\mathrm{T}_{\text {stg }}$ | $-55 \sim 150$ | ${ }^{\circ} \mathrm{C}$ |

* Total rating


## Marking



## Equivalent Circuit (Top View)



Q1 Electrical Characteristics ( $\mathbf{T a}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Collector cut-off current | $\mathrm{I}_{\text {CBO }}$ | - | $\mathrm{V}_{\mathrm{CB}}=-50 \mathrm{~V}, \mathrm{I}_{\mathrm{E}}=0$ | - | - | -100 | nA |
|  | ICEO | - | $\mathrm{V}_{\mathrm{CE}}=-50 \mathrm{~V}, \mathrm{I}_{\mathrm{B}}=0$ | - | - | -500 |  |
| Emitter cut-off current | $\mathrm{I}_{\text {EBO }}$ | - | $\mathrm{V}_{\mathrm{EB}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=0$ | -0.082 | - | -0.15 | mA |
| DC current gain | $\mathrm{h}_{\text {FE }}$ | - | $\mathrm{V}_{C E}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=-10 \mathrm{~mA}$ | 80 | - | - | - |
| Collector-emitter saturation voltage | $\mathrm{V}_{\text {CE (sat) }}$ | - | $\mathrm{I}_{\mathrm{C}}=-5 \mathrm{~mA}, \mathrm{I}_{\mathrm{B}}=-0.25 \mathrm{~mA}$ | - | -0.1 | -0.3 | V |
| Input voltage (ON) | $\mathrm{V}_{1}$ (ON) | - | $\mathrm{V}_{\mathrm{CE}}=-0.2 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=-5 \mathrm{~mA}$ | -1.5 | - | -5.0 | V |
| Input voltage (OFF) | $\mathrm{V}_{1}$ (OFF) | - | $\mathrm{V}_{\mathrm{CE}}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=-0.1 \mathrm{~mA}$ | -1.0 | - | -1.5 | V |
| Transition frequency | $\mathrm{f}_{\mathrm{T}}$ | - | $\mathrm{V}_{\mathrm{CE}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=-5 \mathrm{~mA}$ | - | 200 | - | MHz |
| Collector output capacitance | $\mathrm{C}_{\text {ob }}$ | - | $\mathrm{V}_{\mathrm{CB}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{E}}=0, \mathrm{f}=1 \mathrm{MHz}$ | - | 3 | 6 | pF |

Q2 Electrical Characteristics ( $\mathbf{T a}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Collector cut-off current | Icbo | - | $\mathrm{V}_{\mathrm{CB}}=50 \mathrm{~V}, \mathrm{IE}_{\mathrm{E}}=0$ | - | - | 100 | nA |
|  | Iceo | - | $\mathrm{V}_{\text {CE }}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{B}}=0$ | - | - | 500 |  |
| Emitter cut-off current | Iebo | - | $\mathrm{V}_{\mathrm{EB}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=0$ | 0.082 | - | 0.15 | mA |
| DC current gain | $\mathrm{h}_{\text {FE }}$ | - | $\mathrm{V}_{\mathrm{CE}}=5 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=10 \mathrm{~mA}$ | 80 | - | - | - |
| Collector-emitter saturation voltage | $\mathrm{V}_{\mathrm{CE}}$ (sat) | - | $\mathrm{I}_{\mathrm{C}}=5 \mathrm{~mA}, \mathrm{I}_{\mathrm{B}}=0.25 \mathrm{~mA}$ | - | 0.1 | 0.3 | V |
| Input voltage (ON) | $\mathrm{V}_{1}(\mathrm{ON})$ | - | $\mathrm{V}_{\mathrm{CE}}=0.2 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=5 \mathrm{~mA}$ | 1.5 | - | 5.0 | V |
| Input voltage (OFF) | $\mathrm{V}_{1}$ (OFF) | - | $\mathrm{V}_{\mathrm{CE}}=5 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=0.1 \mathrm{~mA}$ | 1.0 | - | 1.5 | V |
| Transition frequency | $\mathrm{f}_{\mathrm{T}}$ | - | $\mathrm{V}_{\mathrm{CE}}=10 \mathrm{~V}, \mathrm{IC}_{\mathrm{C}}=5 \mathrm{~mA}$ | - | 250 | - | MHz |
| Collector output capacitance | $\mathrm{C}_{\text {ob }}$ | - | $\mathrm{V}_{\mathrm{CB}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{E}}=0, \mathrm{f}=1 \mathrm{MHz}$ | - | 3 | 6 | pF |

Q1, Q2 Common Electrical Characteristics ( $\mathbf{T a}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input resistor | R1 | - | - | 32.9 | 47 | 61.1 | k $\Omega$ |
| Resistor ratio | R1/R2 | - | - | 0.9 | 1.0 | 1.1 | - |







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